

### FEATURES

- Controlled Baseline
  - **One Assembly/Test Site, One Fabrication** Site
- Extended Temperature Performance of -55°C to 125°C
- **Enhanced Diminishing Manufacturing Sources** . (DMS) Support
- **Enhanced Product-Change Notification** .
- Qualification Pedigree (1) •
- Designed for TIA/EIA-485, TIA/EIA-422, and • ISO 8482 Applications
- Signaling Rates up to 30 Mbps <sup>(2)</sup> •
- Propagation Delay Times <11 ns •
- Low Standby Power Consumption 1.5 mA Max •
- **Output ESD Protection Exceeds 13 kV** •
- **Driver Positive- and Negative-Current Limiting**
- Power-Up and Power-Down Glitch Free for • Line-Insertion Applications
- **Thermal Shutdown Protection**
- Industry Standard Pinout, Compatible With SN75174, MC3487, DS96174, LTC487, and **MAX3042**
- (1) Component gualification in accordance with JEDEC and industry standards to ensure reliable operation over an extended temperature range. This includes, but is not limited to, Highly Accelerated Stress Test (HAST) or biased 85/85, temperature cycle, autoclave or unbiased HAST, electromigration, bond intermetallic life, and mold compound life. Such qualification testing should not be viewed as justifying use of this component beyond specified performance and environmental limits.
- (2) The signaling rate of a line is the number of voltage transitions that are made per second, expressed in the unit bits per second (bps).

# DESCRIPTION/ORDERING INFORMATION

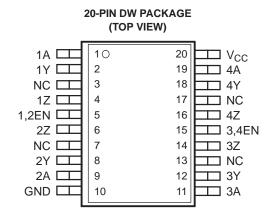
The SN65LBC174A-EP is a guadruple differential line driver with 3-state outputs, designed for TIA/EIA-485 (RS-485), TIA/EIA-422 (RS-422), and ISO 8482 applications.

This device is optimized for balanced multipoint bus transmission at signaling rates up to 30-million bits per second (Mbps). The transmission media may be printed-circuit-board traces, backplanes, or cables. The ultimate rate and distance of data transfer is dependent upon the attenuation characteristics of the media and the noise coupling to the environment.

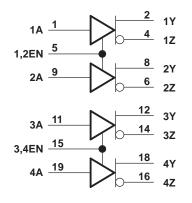
Each driver features current limiting and thermal-shutdown circuitry, making it suitable for high-speed multipoint applications in noisy environments. The device is designed using LinBiCMOS™ technology, facilitating low power consumption and robustness.



Please be aware that an important notice concerning availability, standard warranty, and use in critical applications of Texas Instruments semiconductor products and disclaimers thereto appears at the end of this data sheet. LinBiCMOS is a trademark of Texas Instruments.



### logic diagram (positive logic)





The two enable (EN) inputs provide pair-wise driver enabling, or can be externally tied together to provide enable control of all four drivers with one signal. When disabled or powered off, the driver outputs present a high impedance to the bus for reduced system loading.

The SN65LBC174A-EP is characterized for operation over the temperature range of -55°C to 125°C.

ORDERING INFORMATION									
T <sub>A</sub>	PACKAGE <sup>(1)</sup>	ORDERABLE PART NUMBER	TOP-SIDE MARKING						
–55°C to 125°C	20-pin SOIC – DW	SN65LBC174AMDWREP	65LBC174EP						

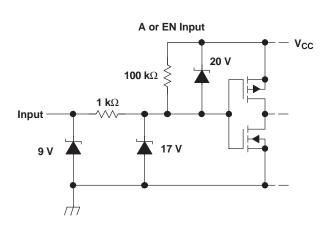
(1) Package drawings, standard packing quantities, thermal data, symbolization, and PCB design guidelines are available at www.ti.com/sc/package.

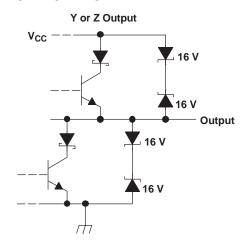
(each driver)								
INPUT	ENABLE	OUTI	PUTS					
Α	G	Y	Z					
L	Н	L	Н					
н	Н	н	L					
OPEN	Н	н	L					
L	OPEN	L	н					
н	OPEN	н	L					
OPEN	OPEN	н	L					
х	L	Z	Z					

#### FUNCTION TABLE<sup>(1)</sup>

(1) H = high level, L = low level, X = irrelevant,
Z = high impedance (off)

#### EQUIVALENT INPUT AND OUTPUT SCHEMATIC DIAGRAMS





### Absolute Maximum Ratings<sup>(1)</sup>

over operating free-air temperature range (unless otherwise noted)

				MIN	MAX	UNIT
$V_{CC}$	Supply voltage range <sup>(2)</sup>			-0.3	6	V
	Voltage range at any bus (dc)				15	V
	Voltage range at any bus (transient pulse through 100 $\Omega$ , see Figure 8)				30	V
VI	Input voltage range at any /	put voltage range at any A or EN terminal		-0.5	V <sub>CC</sub> + 0.5	V
		Human-Body Model <sup>(3)</sup>	Y, Z, and GND		13	
	Electrostatic discharge		All pins		5	kV
		Charged-Device Model <sup>(4)</sup>	All pins		1	
T <sub>stg</sub>	Storage temperature range	(5)		-65	150	°C
	Continuous power dissipation				sipation Rati	ng Table
	Lead temperature 1,6 mm (	(1/16 in) from case for 10 s			260	°C

(1) Stresses beyond those listed under "absolute maximum ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

(2) All voltage values, except differential I/O bus voltages, are with respect to GND.

(3) Tested in accordance with JEDEC standard 22, Test Method A114-A.

(4) Tested in accordance with JEDEC standard 22, Test Method C101.

(5) Long-term high-temperature storage and/or extended use at maximum recommended operating conditions may result in a reduction of overall device life. See http://www.ti.com/ep\_quality for additional information on enhanced plastic packaging.

#### **DISSIPATION RATING TABLE**

PACKAGE	JEDEC BOARD MODEL	T <sub>A</sub> ≤ 25°C POWER RATING	DERATING FACTOR <sup>(1)</sup> ABOVE $T_A = 25^{\circ}C$	T <sub>A</sub> = 70°C POWER RATING	T <sub>A</sub> = 125°C POWER RATING
20 pip DW	Low K	1483 mW	11.86 mW/°C	949 mW	297 mW
20-pin DW	High K	2753 mW	22 mW/°C	1762 mW	553 mW

(1) This is the inverse of the junction-to-ambient thermal resistance when board mounted with no air flow.

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#### **Recommended Operating Conditions**

			MIN	NOM	MAX	UNIT
$V_{CC}$	Supply voltage		4.75	5	5.25	V
	Voltage at any bus terminal	Y, Z	-7		12	V
$V_{\text{IH}}$	High-level input voltage	A, EN	2		$V_{CC}$	V
VIL	Low-level input voltage	A, EN	0		0.8	V
	Output current		-60		60	mA
T <sub>A</sub>	Operating free-air temperature		-55		125	°C

#### **Electrical Characteristics**

over recommended operating conditions

	PARAMETER	TEST CON	DITIONS	MIN	TYP <sup>(1)</sup>	MAX	UNIT
V <sub>IK</sub>	Input clamp voltage	I <sub>I</sub> = -18 mA	-1.5	-0.77		V	
Vo	Open-circuit output voltage	Y or Z, No load		0		$V_{CC}$	V
		No load (open circuit)		3		$V_{CC}$	
V <sub>OD(SS)</sub>	Steady-state differential output voltage magnitude <sup>(2)</sup>	$R_L = 54 \Omega$ , See Figure 1		0.8	1.6	2.5	V
	Voltago maginado v	With common-mode load	ling, See Figure 2	0.8	1.6	2.5	
$\Delta V_{OD(SS)}$	Change in steady-state differential output voltage between logic states	See Figure 1	-0.1		0.1	V	
V <sub>OC(SS)</sub>	Steady-state common-mode output voltage	See Figure 3	2	2.4	2.8	V	
$\Delta V_{OC(SS)}$	Change in steady-state common-mode output voltage between logic states	See Figure 3	-0.04		0.04	V	
I <sub>I</sub>	Input current	A, G, <del>G</del>		70		70	μA
I <sub>OS</sub>	Short-circuit output current	$V_{\text{TEST}} = -7 \text{ V to } 12 \text{ V},$	$V_{I} = 0 V$ $V_{I} = V_{CC}$	-200		200	mA
I <sub>OZ</sub>	High-impedance-state output current	See Figure 7	EN at 0 V	-50		50	•
I <sub>O(OFF)</sub>	Output current with power off	1	$V_{CC} = 0 V$	-10		10	μA
	Supply surrent	$V_I = 0 V \text{ or } V_{CC}$ , All drivers enabled				25	
I <sub>CC</sub>	Supply current	No load	All drivers disabled			1.5	mA

All typical values are at V<sub>CC</sub> = 5 V and 25°C.
The minimum V<sub>OD</sub> may not fully comply with TIA/EIA-485-A at operating temperatures below 0°C. System designers should take the possibility of lower output signal into account in determining the maximum signal transmission distance.

#### **Switching Characteristics**

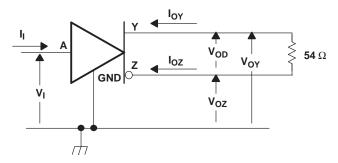
over recommended operating conditions

	PARAMETER	TEST CO	NDITIONS	MIN	TYP	MAX	UNIT
	Propagation delay time, low- to high-level output		T <sub>A</sub> =25°C	4.0	8	11	ns
t <sub>PLH</sub>			$T_A$ = -55°C to 125°C	4.0		16	ns
+	Propagation delay time, high- to low-level output		T <sub>A</sub> =25°C	4.0	8	11	ns
t <sub>PHL</sub>			$T_A$ = -55°C to 125°C	4.0		16	ns
+	Differential output voltage rise time		T <sub>A</sub> =25°C	3	7.5	11	ns
t <sub>r</sub>	Differential output voltage lise time	$R_L = 54 \Omega, C_L = 50 pF,$	$T_A$ = -55°C to 125°C	3		24	ns
+	Differential output voltage fall time	See Figure 4	T <sub>A</sub> =25°C	3	7.5	11	ns
t <sub>f</sub>			$T_A$ = -55°C to 125°C	3		24	ns
+	Pulse skew  t <sub>PLH</sub> – t <sub>PHL</sub>				0.6		ns
t <sub>sk(p)</sub>					0.6		115
t <sub>sk(o)</sub>	Output skew <sup>(1)</sup>				2		ns
t <sub>sk(pp)</sub>	Part-to-part skew <sup>(2)</sup>				3		ns
t <sub>PZH</sub>	Propagation delay time, high impedance to high-level output	See Figure F				25	ns
t <sub>PHZ</sub>	Propagation delay time, high-level output to high impedance	See Figure 5				25	ns
t <sub>PZL</sub>	Propagation delay time, high impedance to low-level output	Cas Firme C				30	ns
t <sub>PLZ</sub>	Propagation delay time, low-level output to high impedance	See Figure 6			20	ns	

(1) Output skew (t<sub>sk(o)</sub>) is the magnitude of the time delay difference between the outputs of a single device with all of the inputs connected together.

(2) Part-to-part skew (t<sub>sk(pp)</sub>) is the magnitude of the difference in propagation delay times between any specified terminals of two devices when both devices operate with the same input signals, the same supply voltages, at the same temperature, and have identical packages and test circuits.

#### PARAMETER MEASUREMENT INFORMATION





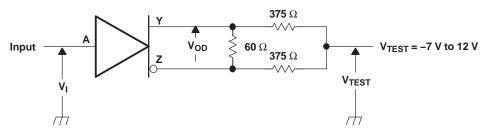
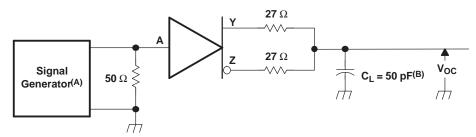


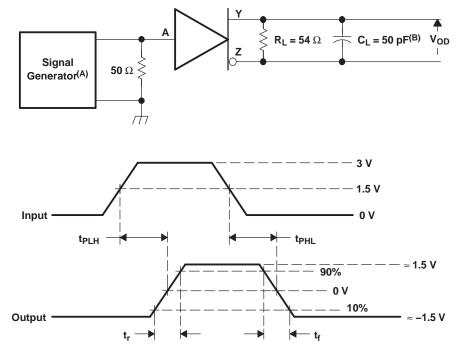
Figure 2. Test Circuit,  $\mathrm{V}_{\mathrm{OD}}$  With Common-Mode Loading



- A. PRR = 1 MHz, 50% duty cycle,  $t_r < 6$  ns,  $t_f < 6$  ns,  $Z_0 = 50 \Omega$
- B. Includes probe and jig capacitance

#### Figure 3. V<sub>oc</sub> Test Circuit

#### PARAMETER MEASUREMENT INFORMATION (continued)



- A. PRR = 1 MHz, 50% duty cycle,  $t_r\,$  < 6 ns,  $t_f\,$  < 6 ns,  $Z_O$  = 50  $\Omega$
- B. Includes probe and jig capacitance

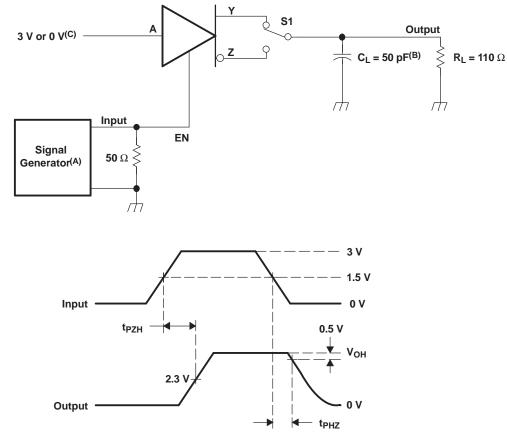
#### Figure 4. Output Switching Test Circuit and Waveforms

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#### **PARAMETER MEASUREMENT INFORMATION (continued)**

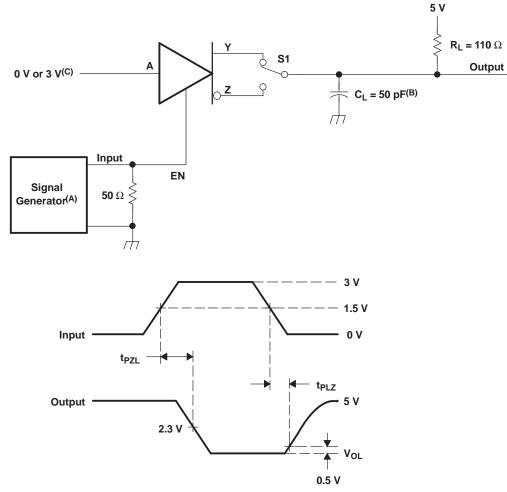


- A. PRR = 1 MHz, 50% duty cycle,  $t_r < 6$  ns,  $t_f < 6$  ns,  $Z_0 = 50 \Omega$
- B. Includes probe and jig capacitance
- C. 3 V if testing Y output, 0 V if testing Z output

## Figure 5. Enable Timing Test Circuit and Waveforms, $t_{\text{PZH}}$ and $t_{\text{PHZ}}$



#### PARAMETER MEASUREMENT INFORMATION (continued)



- A. PRR = 1 MHz, 50% duty cycle,  $t_r$  < 6 ns,  $t_f$  < 6 ns,  $Z_O$  = 50  $\Omega$
- B. Includes probe and jig capacitance
- C. 3 V if testing Y output, 0 V if testing Z output

#### Figure 6. Enable Timing Test Circuit and Waveforms, $t_{\text{PZL}}$ and $t_{\text{PLZ}}$

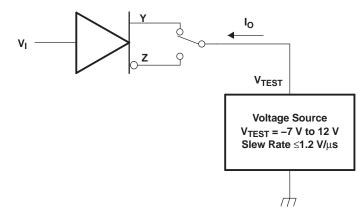


Figure 7. Test Circuit, Short-Circuit Output Current



## PARAMETER MEASUREMENT INFORMATION (continued)

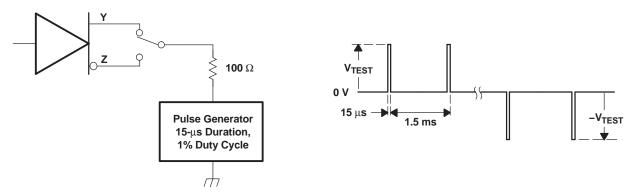
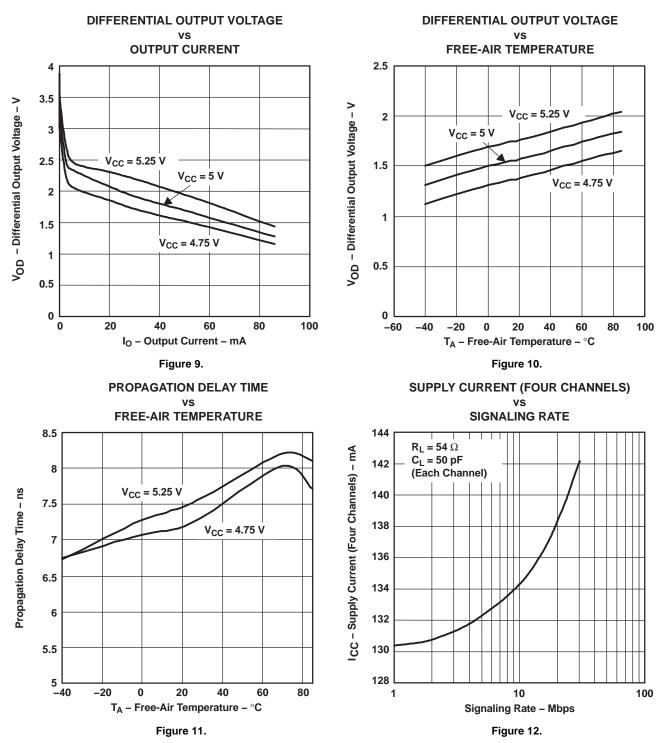


Figure 8. Test Circuit Waveform, Transient Overvoltage Test

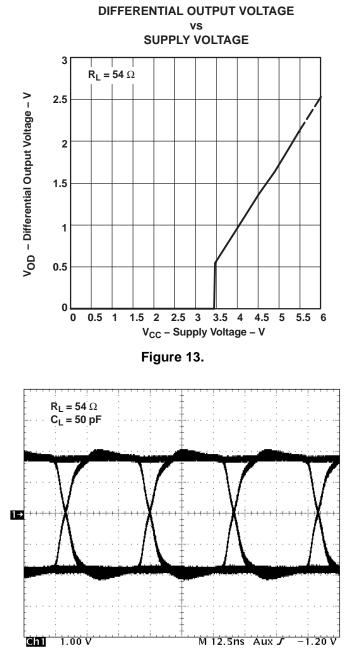


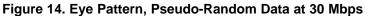
**TYPICAL CHARACTERISTICS** 





### **TYPICAL CHARACTERISTICS (continued)**

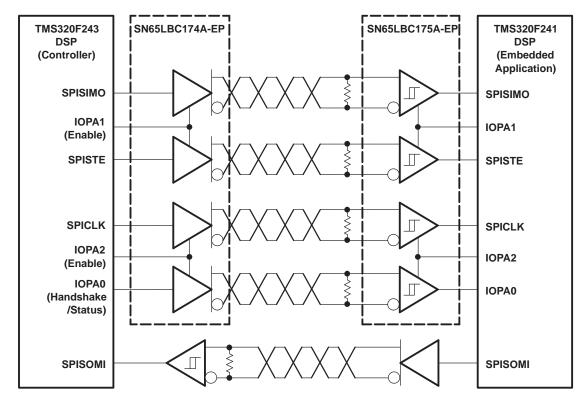




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**APPLICATION INFORMATION** 

Figure 15. Typical Application Circuit, DSP-to-DSP Link Via Serial Peripheral Interface

#### PACKAGING INFORMATION

Orderable Device	Status <sup>(1)</sup>	Package Type	Package Drawing	Pins Pa	ackage Qty	e Eco Plan <sup>(2)</sup>	Lead/Ball Finish	MSL Peak Temp <sup>(3)</sup>
SN65LBC174AMDWREP	ACTIVE	SOIC	DW	20	2000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM
V62/07611-01XE	ACTIVE	SOIC	DW	20	2000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM

<sup>(1)</sup> The marketing status values are defined as follows:

ACTIVE: Product device recommended for new designs.

LIFEBUY: TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.

NRND: Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design.

PREVIEW: Device has been announced but is not in production. Samples may or may not be available.

**OBSOLETE:** TI has discontinued the production of the device.

<sup>(2)</sup> Eco Plan - The planned eco-friendly classification: Pb-Free (RoHS), Pb-Free (RoHS Exempt), or Green (RoHS & no Sb/Br) - please check http://www.ti.com/productcontent for the latest availability information and additional product content details. **TBD:** The Pb-Free/Green conversion plan has not been defined.

**Pb-Free (RoHS):** TI's terms "Lead-Free" or "Pb-Free" mean semiconductor products that are compatible with the current RoHS requirements for all 6 substances, including the requirement that lead not exceed 0.1% by weight in homogeneous materials. Where designed to be soldered at high temperatures, TI Pb-Free products are suitable for use in specified lead-free processes.

**Pb-Free (RoHS Exempt):** This component has a RoHS exemption for either 1) lead-based flip-chip solder bumps used between the die and package, or 2) lead-based die adhesive used between the die and leadframe. The component is otherwise considered Pb-Free (RoHS compatible) as defined above.

Green (RoHS & no Sb/Br): TI defines "Green" to mean Pb-Free (RoHS compatible), and free of Bromine (Br) and Antimony (Sb) based flame retardants (Br or Sb do not exceed 0.1% by weight in homogeneous material)

<sup>(3)</sup> MSL, Peak Temp. -- The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.

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#### OTHER QUALIFIED VERSIONS OF SN65LBC174A-EP :

• Catalog: SN65LBC174A

NOTE: Qualified Version Definitions:

• Catalog - TI's standard catalog product

### TAPE AND REEL INFORMATION





## QUADRANT ASSIGNMENTS FOR PIN 1 ORIENTATION IN TAPE



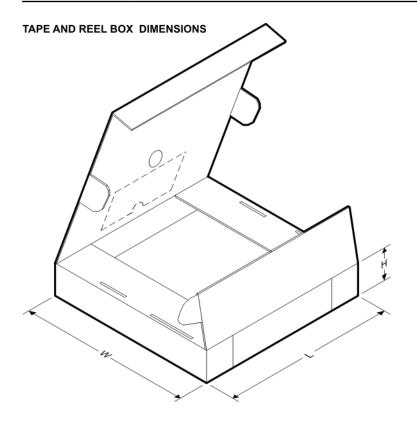
*All dimensions are nominal
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Device		Package Drawing			Reel Diameter (mm)	Reel Width W1 (mm)	A0 (mm)	B0 (mm)	K0 (mm)	P1 (mm)	W (mm)	Pin1 Quadrant
SN65LBC174AMDWREP	SOIC	DW	20	2000	330.0	24.4	10.8	13.1	2.65	12.0	24.0	Q1



# PACKAGE MATERIALS INFORMATION

16-Jul-2008



\*All dimensions are nominal

Device	Package Type	Package Drawing	Pins	SPQ	Length (mm)	Width (mm)	Height (mm)
SN65LBC174AMDWREP	SOIC	DW	20	2000	346.0	346.0	41.0

DW (R-PDSO-G20)

PLASTIC SMALL-OUTLINE PACKAGE



NOTES: A. All linear dimensions are in inches (millimeters).

B. This drawing is subject to change without notice.

C. Body dimensions do not include mold flash or protrusion not to exceed 0.006 (0,15).

D. Falls within JEDEC MS-013 variation AC.



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